FAIRCHILD

SEMICONDUCTOR®

FGP20N60UFD 600V, 20A Field Stop IGBT

Features

- High current capability
- Low saturation voltage: V_{CE(sat)} =1.8V @ I_C = 20A
- High input impedance
- Fast switching
- RoHS compliant

Applications

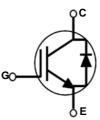
• Induction Heating, UPS, SMPS, PFC



General Description

Using Novel Field Stop IGBT Technology, Fairchild's new series of Field Stop IGBTs offer the optimum performance for Induction Heating, UPS, SMPS and PFC applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

Symbol	Description	Ratings	Units	
V _{CES}	Collector to Emitter Voltage		600	V
V _{GES}	Gate to Emitter Voltage		± 20	V
I _C	Collector Current	@ T _C = 25 ^o C	40	А
	Collector Current	@ T _C = 100°C	20	А
I _{CM (1)}	Pulsed Collector Current	@ T _C = 25 ^o C	60	А
P _D	Maximum Power Dissipation	@ T _C = 25°C	165	W
·D	Maximum Power Dissipation	@ $T_{\rm C} = 100^{\rm o}{\rm C}$	66	W
TJ	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
Τ _L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

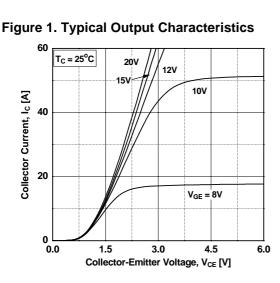
Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$ (IGBT)	$R_{\theta JC}$ (IGBT) Thermal Resistance, Junction to Case		0.76	°C/W
R _{0JC} (Diode) Thermal Resistance, Junction to Case		-	2.51	°C/W
R _{0JA} Thermal Resistance, Junction to Ambient		-	62.5	°C/W

October 2008

		Ackage Packaging Type TO-220 Tube		Qty per Tube		Max Qty per Box			
				50)ea	-			
			14						
Electric	al Chai	racteristics of th	ne ic	BI T _C = 25	5°C unless otherwise noted	1	1		1
Symbol	ol Parameter			Test	Conditions	Min.	Тур.	Max.	Units
Off Charac	teristics								
BV _{CES}		to Emitter Breakdown Vo	Itage	V _{GE} = 0V, I _C	s = 250µA	600	-	_	V
$\frac{\Delta BV_{CES}}{\Delta T_{J}}$			$V_{GE} = 0V, I_C$		-	0.6	-	V/ºC	
I _{CES}	-	Cut-Off Current		$V_{CE} = V_{CES}, V_{GE} = 0V, T_{C} = 25^{\circ}C$		-	-	250	μA
010				$V_{CE} = V_{CES}, V_{GE} = 0V,$ $T_{C} = 125^{\circ}C$		-	-	1	mA
I _{GES}	G-E Leak	age Current	$V_{GE} = V_{GES}, V_{CE} = 0V$, V _{CE} = 0V	-	-	±400	nA
On Charac		abold Voltage		L _ 050 A	<u> </u>	4.0	5.0	6 F	V
V _{GE(th)}	GE(th) G-E Threshold Voltage V _{GE(sat)} Collector to Emitter Saturation Voltage		$I_{\rm C} = 250 \mu {\rm A},$		4.0	5.0	6.5		
V _{CE(sat)}			tage	$I_{C} = 20A, V_{GE} = 15V$ $I_{C} = 20A, V_{GE} = 15V,$		-	1.8	2.4	V
02(000)				$T_{\rm C} = 20 {\rm A}, V_{\rm G}$ $T_{\rm C} = 125^{\rm o}{\rm C}$	E = 13V,	-	2.0	-	V
Dynamic C	haracteris	tics							
Cies	Input Cap	pacitance				-	940	-	pF
C _{oes}	Output Ca	apacitance		V _{CE} = 30V, \ f = 1MHz	/ _{GE} = 0V,	-	110	-	pF
C _{res}	Reverse ⁻	Transfer Capacitance				-	40	-	pF
Switching	Characteri	istics							
-	-	Delay Time				-	13	_	ns
t _{d(on)} t _r	Rise Time			V _{CC} = 400V, I _C = 20A,		-	10	-	ns
t _{d(off)}		Delay Time				-	87	-	ns
t _f	Fall Time			R _G = 10Ω, V	/ _{GE} = 15V,	-	32	64	ns
E _{on}		Switching Loss		Inductive Lo	ad, T _C = 25°C	-	0.38	-	mJ
E _{off}	Turn-Off S	Switching Loss				-	0.26	-	mJ
E _{ts}	Total Swit	ching Loss				-	0.64	-	mJ
t _{d(on)}	Turn-On [Delay Time				-	13	-	ns
t _r	Rise Time	9				-	16	-	ns
t _{d(off)}	Turn-Off [Delay Time		V _{CC} = 400V,	, I _C = 20A,	-	92	-	ns
t _f	Fall Time			R _G = 10Ω, V	′ _{GE} = 15V,	-	63	-	ns
Eon	Turn-On S	Switching Loss		Inductive Load, T _C = 125°C		-	0.41	-	mJ
E _{off}	Turn-Off S	Switching Loss		1		-	0.36	-	mJ
E _{ts}	Total Swit	ching Loss		1		-	0.77	-	mJ
Qg	Total Gate	e Charge				-	63	-	nC
Q _{ge}	Gate to E	mitter Charge		V _{CE} = 400V, V _{GE} = 15V	I _C = 20A,	-	7	-	nC
Q _{gc}	Gate to C	ollector Charge		*GE - 15 V		-	32	-	nC

Symbol	Parameter	Test Condition	าร	Min.	Тур.	Max	Units
V _{FM}	Diode Forward Voltage	I _F = 10A	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	1.9	2.5	V
FM Diodo Forward Volage	Diodo i olivara voltago	F = 10/1	$T_{\rm C} = 125^{\rm o}{\rm C}$	-	1.7	-	
t _{rr}	Diode Reverse Recovery Time		$T_{\rm C} = 25^{\rm o}{\rm C}$	-	- 35	-	ns
•rr		I _{ES} =10A, dI _{ES} /dt = 200A/μs	$T_{\rm C} = 125^{\rm o}{\rm C}$	-	57	-	
Q _{rr}	Diode Reverse Recovery Charge	$125 - 107, 0125/01 - 2007/\mu 3$	T _C = 25°C	-	41	-	nC
~			$T_{\rm C} = 125^{\rm o}{\rm C}$	-	96	-	

Electrical Characteristics of the Diode T_c = 25°C unless otherwise noted



Typical Performance Characteristics

Figure 3. Typical Saturation Voltage Characteristics

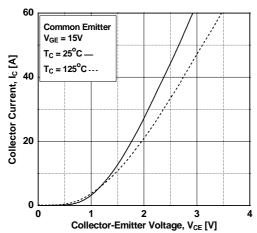


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

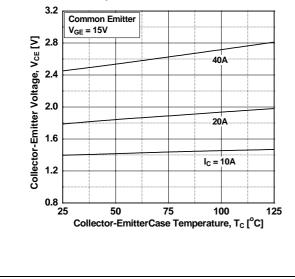


Figure 2. Typical Output Characteristics

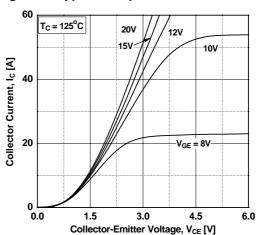


Figure 4. Transfer Characteristics

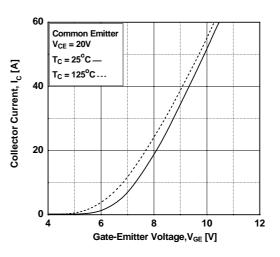
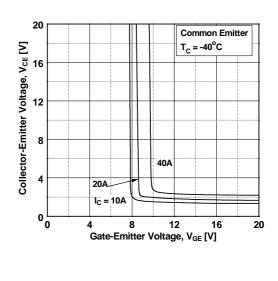
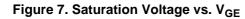


Figure 6. Saturation Voltage vs. V_{GE}



Typical Performance Characteristics



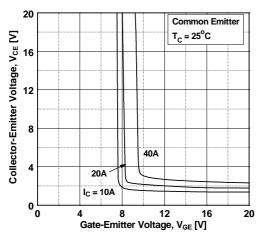


Figure 9. Capacitance Characteristics

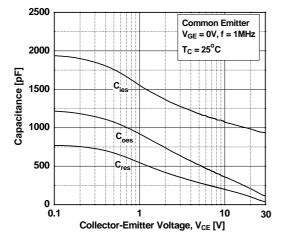


Figure 11. SOA Characteristics

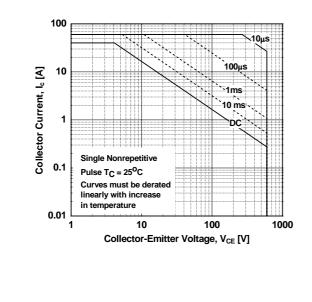


Figure 8. Saturation Voltage vs. V_{GE}

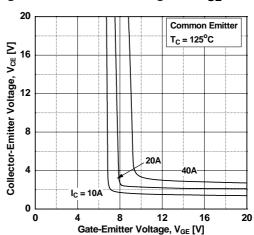


Figure 10. Gate charge Characteristics

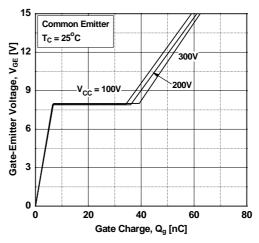
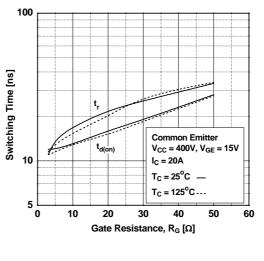
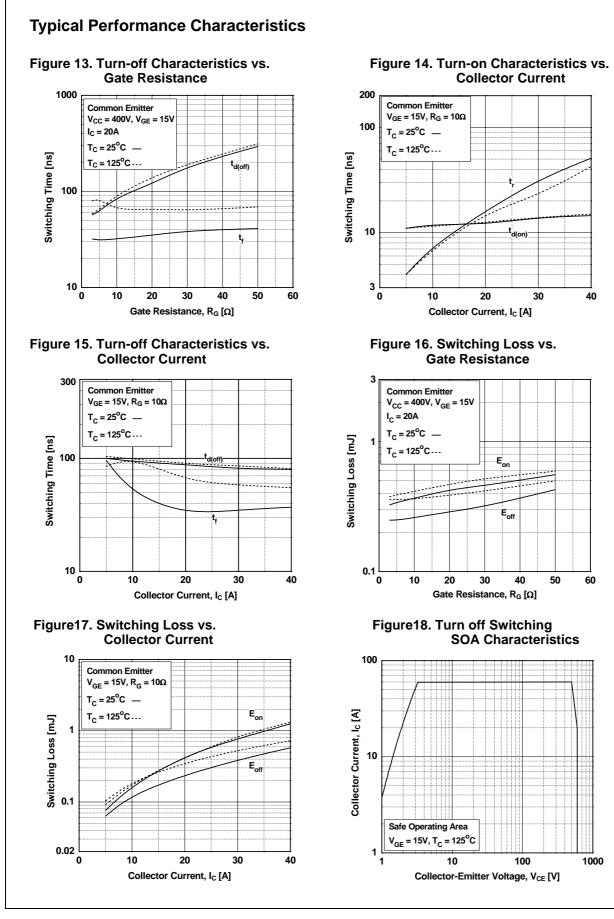
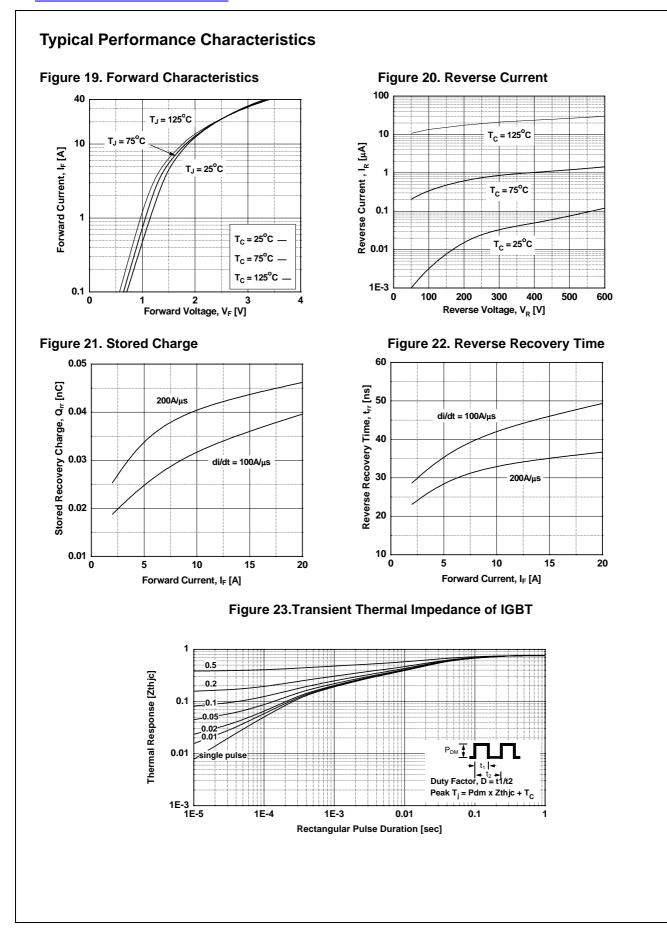
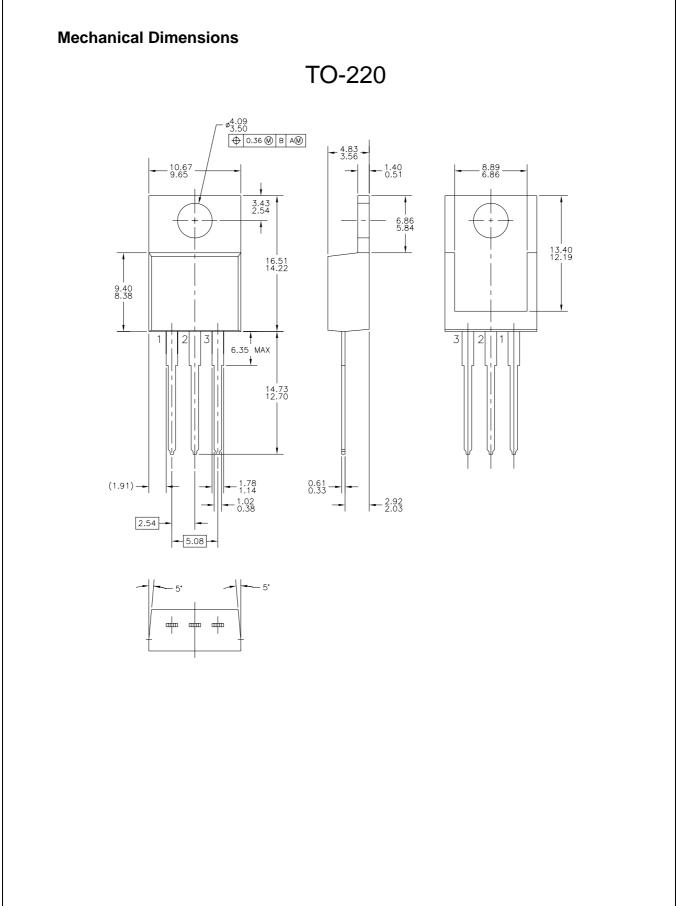


Figure 12. Turn-on Characteristics vs. Gate Resistance









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